

BUK7L11-34ARC

N-channel TrenchPLUS standard level FET

Rev. 05 — 17 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include internal gate resistors and TrenchPLUS diodes for clamping and ElectroStatic Discharge (ESD) protection. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated gate resistor

1.3 Applications

- 12 V loads
- Automotive systems
- General purpose power switching
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference

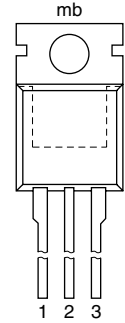
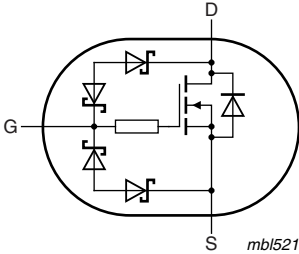
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_D	drain current	$V_{GS} = 10\text{ V}$; $T_{mb} = 25\text{ °C}$; see Figure 1 ; see Figure 3	[1]	-	-	89 A
			[2]			
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; see Figure 2	-	-	172	W
Static characteristics						
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}$; $I_D = 30\text{ A}$; $T_j = 25\text{ °C}$; see Figure 14 ; see Figure 6	-	8	11	mΩ

[1] Current is limited by power dissipation chip rating.

[2] Refer to document 9397 750 12572 for further information.

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain		
3	S	source		
mb	D	mounting base; connected to drain		
			SOT78C (TO-220AB)	

3. Ordering information

Table 3. Ordering information

Type number	Package		Version
	Name	Description	
BUK7L11-34ARC	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-leads	SOT78C

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

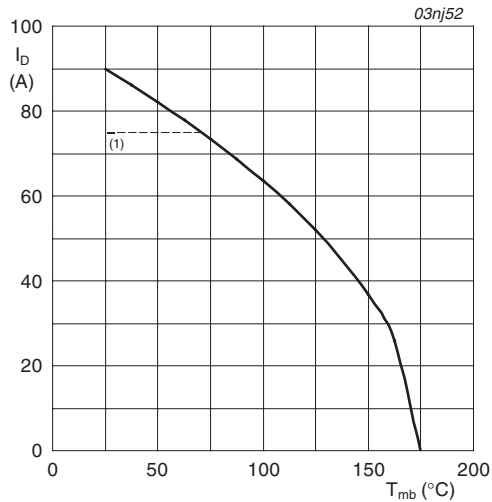
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	[1]	-	34	V
V _{DGR}	drain-gate voltage	R _{GS} = 20 kΩ	[1]	-	34	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see Figure 1 ; see Figure 3	[2][3]	-	89	A
			[4]	-	75	A
		T _{mb} = 100 °C; V _{GS} = 10 V; see Figure 1		-	63	A
I _{DM}	peak drain current	T _{mb} = 25 °C; t _p ≤ 10 μs; pulsed; see Figure 3		-	358	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see Figure 2		-	172	W
I _{DG(CL)}	drain-gate clamping current	pulsed; t _p = 5 ms; δ = 0.01		-	50	mA
I _{GS(CL)}	gate-source clamping current			-	50	mA
		continuous		-	10	mA
T _{stg}	storage temperature			-55	175	°C
T _j	junction temperature			-55	175	°C
Source-drain diode						
I _S	source current	T _{mb} = 25 °C	[2][3]	-	89	A
			[4]	-	75	A
I _{SM}	peak source current	t _p ≤ 10 μs; pulsed; T _{mb} = 25 °C		-	358	A
Avalanche ruggedness						
E _{DS(CL)S}	non-repetitive drain-source clamping energy	I _D = 60 A; V _{DS} ≤ 34 V; V _{GS} = 10 V; R _{GS} = 50 Ω; unclamped; T _{j(init)} = 25 °C		-	465	mJ
Electrostatic discharge						
V _{esd}	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 kΩ		-	6	kV
		HBM; C = 100 pF; R = 1.5 kΩ		-	8	kV

[1] Voltage is limited by clamping.

[2] Current is limited by power dissipation chip rating.

[3] Refer to document 9397 750 12572 for further information.

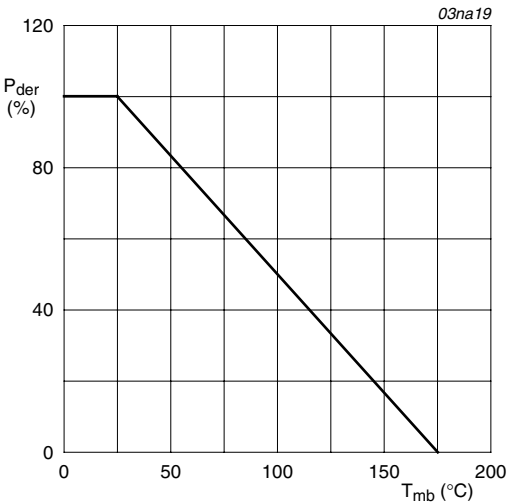
[4] Continuous current is limited by package.



$V_{GS} \geq 10V$

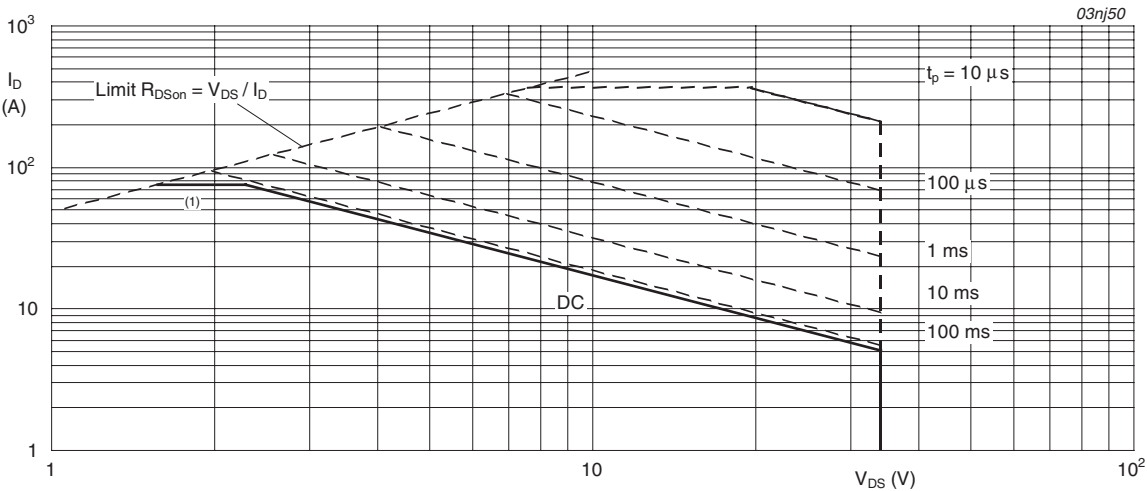
(1) Capped at 75 A due to package

Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



$T_{mb} = 25^{\circ}C; I_{DM}$ is single pulse

(1) Capped at 75 A due to package

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in free air	-	60	-	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.55	0.87	K/W

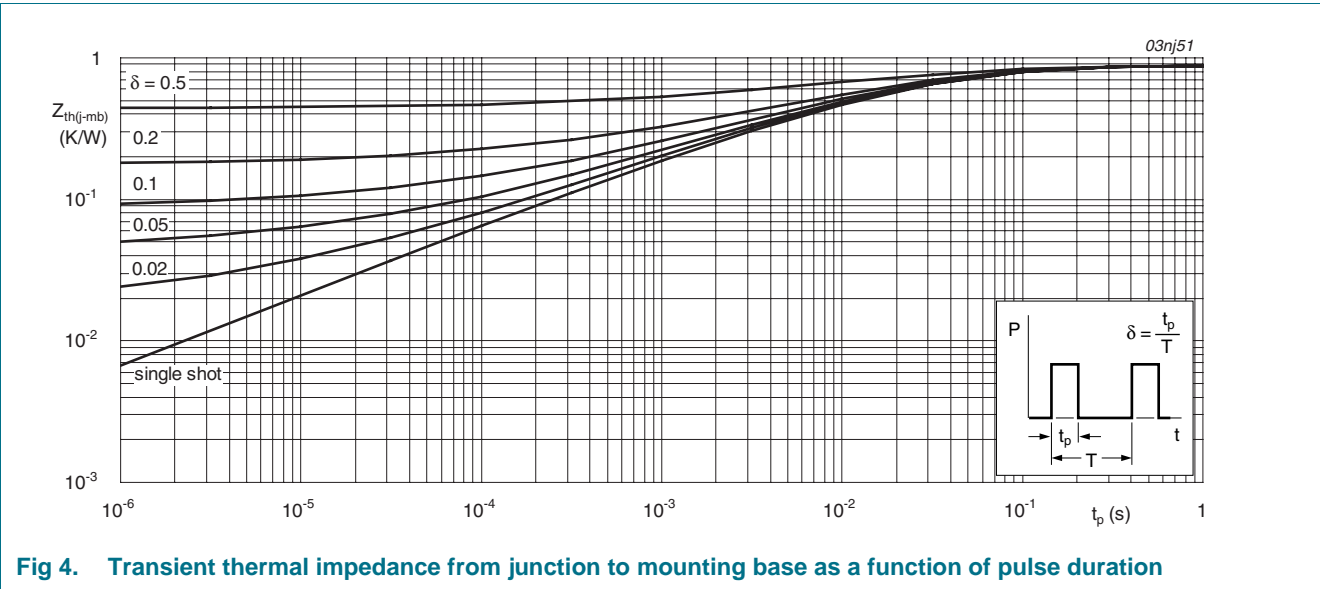


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

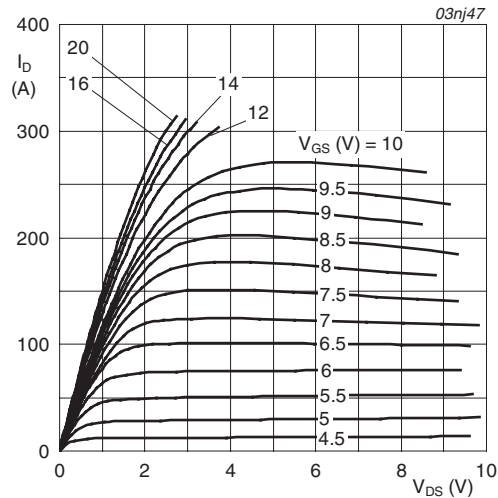
6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DG}$	drain-gate (Zener diode) breakdown voltage	$I_D = 1 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$	34	-	45	V
		$I_D = 1 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ }^\circ\text{C}$	34	-	45	V
$V_{DS(CL)}$	drain-source clamping voltage	$I_{GS(CL)} = -2 \text{ mA}; I_D = 1 \text{ A}; T_j = 25 \text{ }^\circ\text{C};$ see Figure 12 ; see Figure 18	-	41	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ\text{C};$ see Figure 13 ; see Figure 7	2.2	3	3.8	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ }^\circ\text{C};$ see Figure 13 ; see Figure 7	1.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ }^\circ\text{C};$ see Figure 13 ; see Figure 7	1.2	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ }^\circ\text{C};$ see Figure 13 ; see Figure 7	-	-	4.2	V
I_{DSS}	drain leakage current	$V_{DS} = 16 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$	-	0.1	2	μA
		$V_{DS} = 16 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ }^\circ\text{C}$	-	3	50	μA
		$V_{DS} = 16 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ }^\circ\text{C}$	-	18	250	μA
$V_{(BR)GSS}$	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ }^\circ\text{C};$ $T_j < 175 \text{ }^\circ\text{C};$ see Figure 18 ; see Figure 19	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ }^\circ\text{C};$ $T_j < 175 \text{ }^\circ\text{C};$ see Figure 18 ; see Figure 19	20	22	-	V
I_{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$	-	5	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$	-	5	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 175 \text{ }^\circ\text{C}$	-	-	50	μA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 \text{ }^\circ\text{C}$	-	-	50	μA
		$V_{DS} = 0 \text{ V}; V_{GS} = 16 \text{ V}; T_j = 175 \text{ }^\circ\text{C}$	-	-	150	μA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A}; T_j = 25 \text{ }^\circ\text{C};$ see Figure 14 ; see Figure 6	-	8	11	m Ω
		$V_{GS} = 10 \text{ V}; I_D = 30 \text{ A}; T_j = 175 \text{ }^\circ\text{C};$ see Figure 14 ; see Figure 6	-	-	20.9	m Ω
		$V_{GS} = 16 \text{ V}; I_D = 30 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$	-	7	9.7	m Ω
R_G	internal gate resistance (AC)	$f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ\text{C}$	-	11	-	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 27 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ see Figure 16	-	53	-	nC
Q_{GS}	gate-source charge		-	11	-	nC
Q_{GD}	gate-drain charge		-	20	-	nC
C_{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ }^\circ\text{C};$ see Figure 17	-	1880	2506	pF
C_{oss}	output capacitance		-	640	768	pF
C_{rss}	reverse transfer capacitance		-	400	548	pF

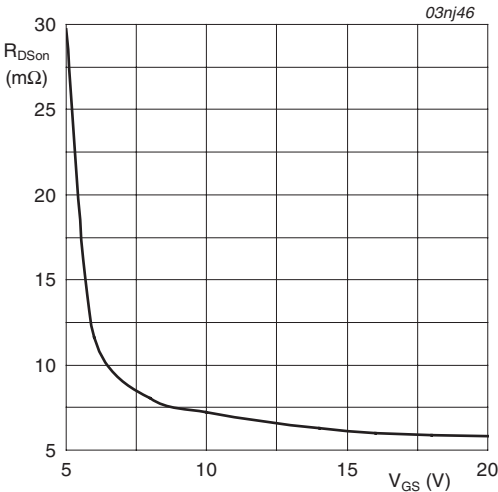
Table 6. Characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	turn-on delay time	$V_{DS} = 30\text{ V}; R_L = 1.2\ \Omega; V_{GS} = 10\text{ V};$ $R_{G(ext)} = 10\ \Omega; T_j = 25\text{ }^\circ\text{C}$	-	20	-	ns
t_r	rise time		-	92	-	ns
$t_{d(off)}$	turn-off delay time		-	127	-	ns
t_f	fall time		-	118	-	ns
L_D	internal drain inductance	measured from contact screw on mounting base to centre of die; $T_j = 25\text{ }^\circ\text{C}$	-	3.5	-	nH
		measured from drain lead 6 mm from package to centre of die; $T_j = 25\text{ }^\circ\text{C}$	-	4.5	-	nH
L_S	internal source inductance	measured from source lead to source bond pad; $T_j = 25\text{ }^\circ\text{C}$	-	7.5	-	nH
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 25\text{ A}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C};$ see Figure 15	-	0.85	1.2	V
t_{rr}	reverse recovery time	$I_S = 20\text{ A}; dI_S/dt = -100\text{ A}/\mu\text{s}; V_{GS} = 0\text{ V};$ $V_{DS} = 30\text{ V}; T_j = 25\text{ }^\circ\text{C}$	-	52	-	ns
Q_r	recovered charge		-	28	-	nC



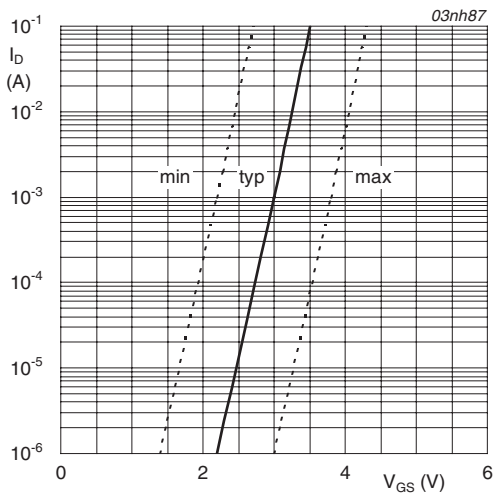
$T_j = 25^{\circ}\text{C}; t_p = 300\mu\text{s}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



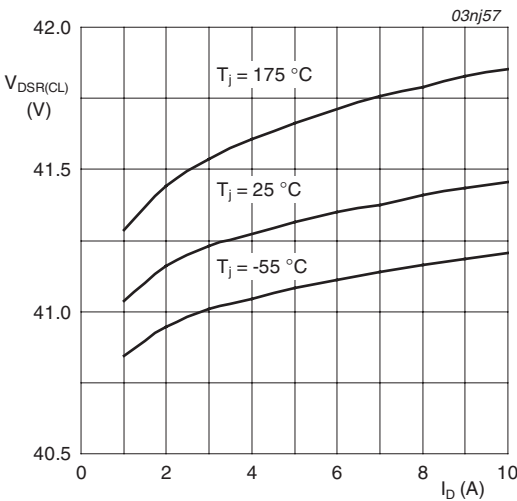
$T_j = 25^{\circ}\text{C}; I_D = 30\text{A}$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



$T_j = 25^{\circ}\text{C}; V_{DS} = V_{GS}$

Fig 7. Sub-threshold drain current as a function of gate-source voltage



$I_G = -2\text{mA}$

Fig 8. Drain-source clamping voltage as a function of drain current; typical values

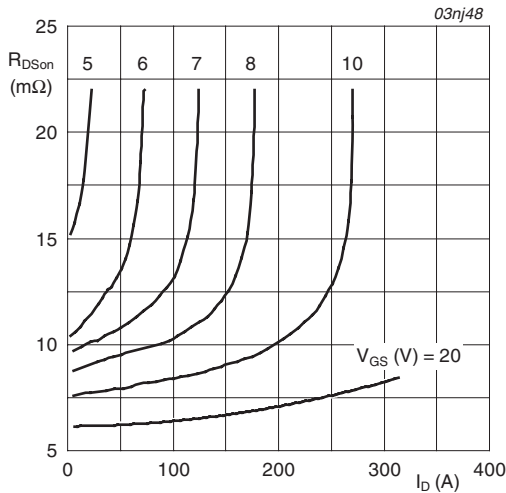


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

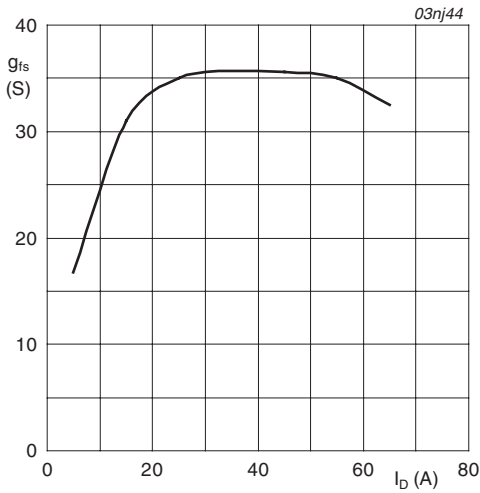


Fig 10. Forward transconductance as a function of drain current; typical values

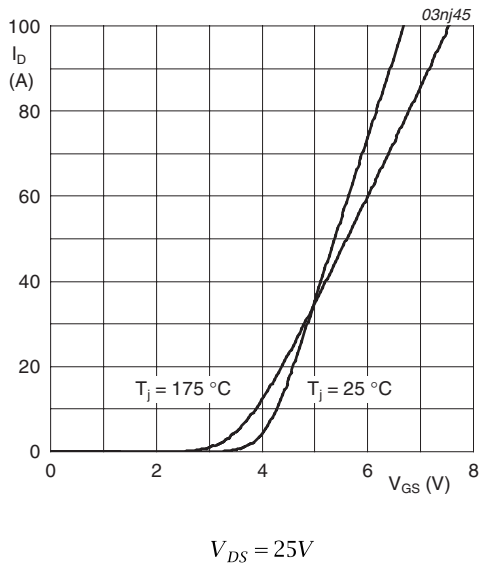


Fig 11. Transfer characteristics: drain current as a function of gate-source voltage; typical values

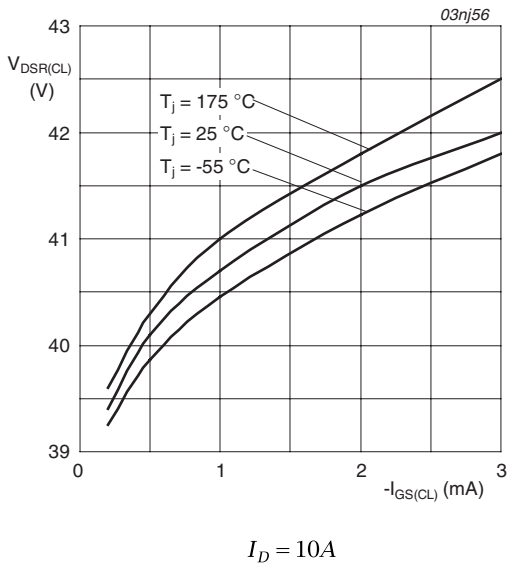
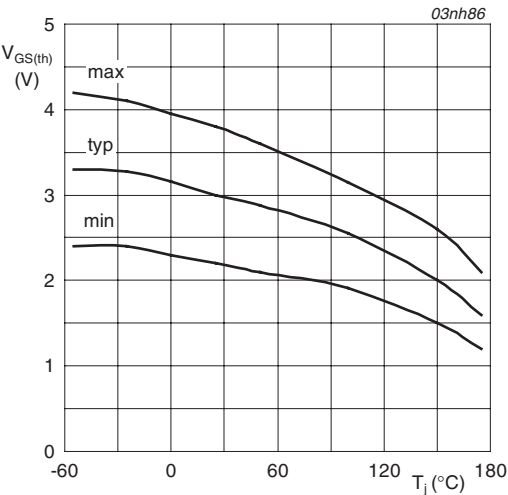
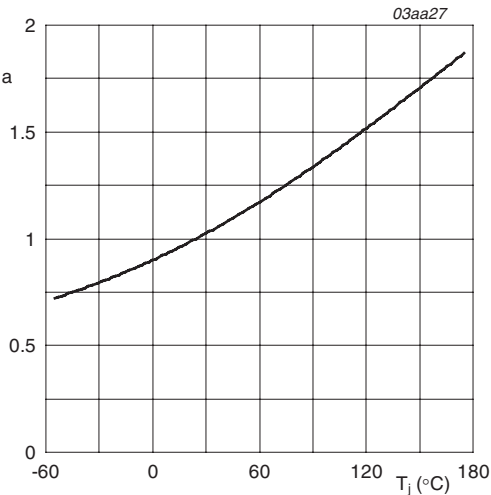


Fig 12. Drain-source clamping voltage as a function of gate-source clamping current; typical values



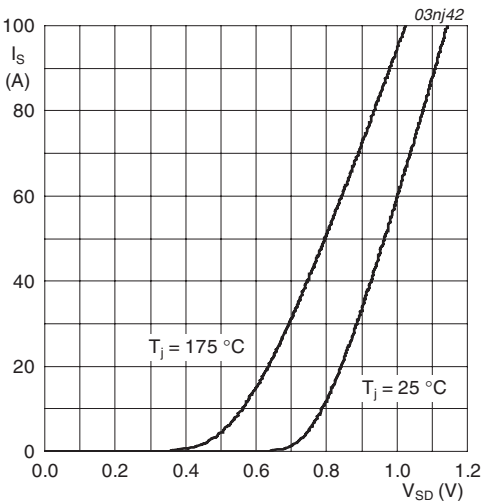
$I_D = 1\text{mA}; V_{DS} = V_{GS}$

Fig 13. Gate-source threshold voltage as a function of junction temperature



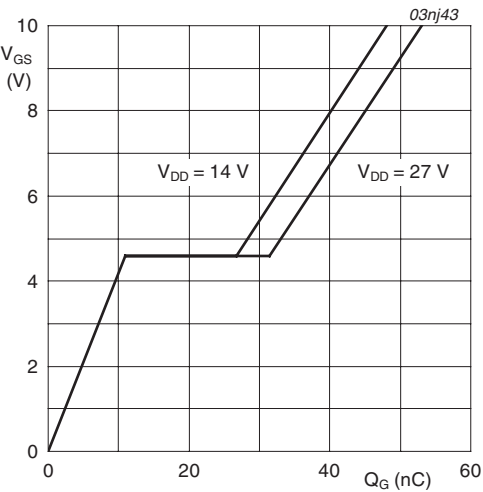
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 14. Normalized drain-source on-state resistance factor as a function of junction temperature



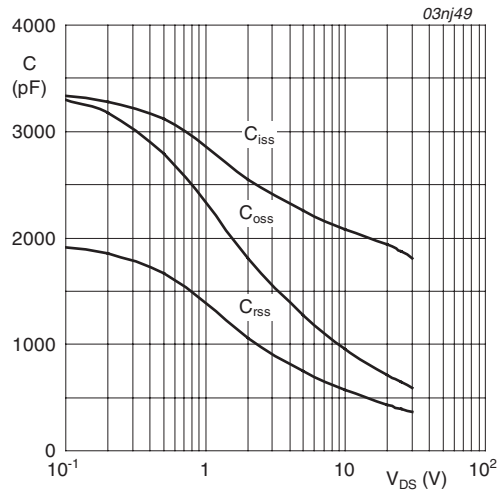
$V_{GS} = 0\text{V}$

Fig 15. Source current as a function of source-drain voltage; typical values



$T_j = 25^\circ\text{C}; I_D = 25\text{A}$

Fig 16. Gate-source voltage as a function of gate charge; typical values



$$V_{GS} = 0V; f = 1MHz$$

Fig 17. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

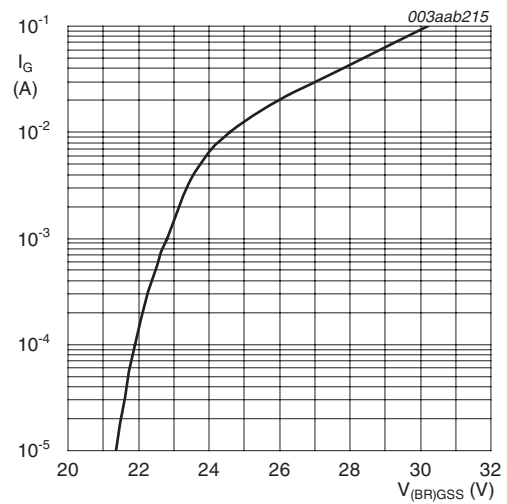
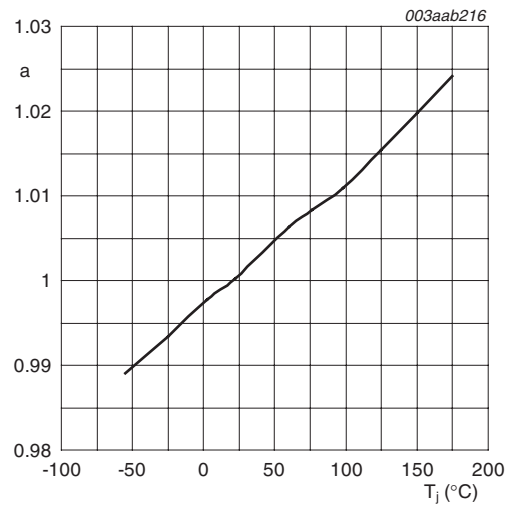


Fig 18. Source-gate clamping current as a function of source-gate clamping voltage; typical values



$$a = \frac{V_{(BR)GSS}}{V_{(BR)GSS(25^{\circ}C)}}$$

Fig 19. Normalized source-gate clamping voltage as a function of junction temperature; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3 leads

SOT78C

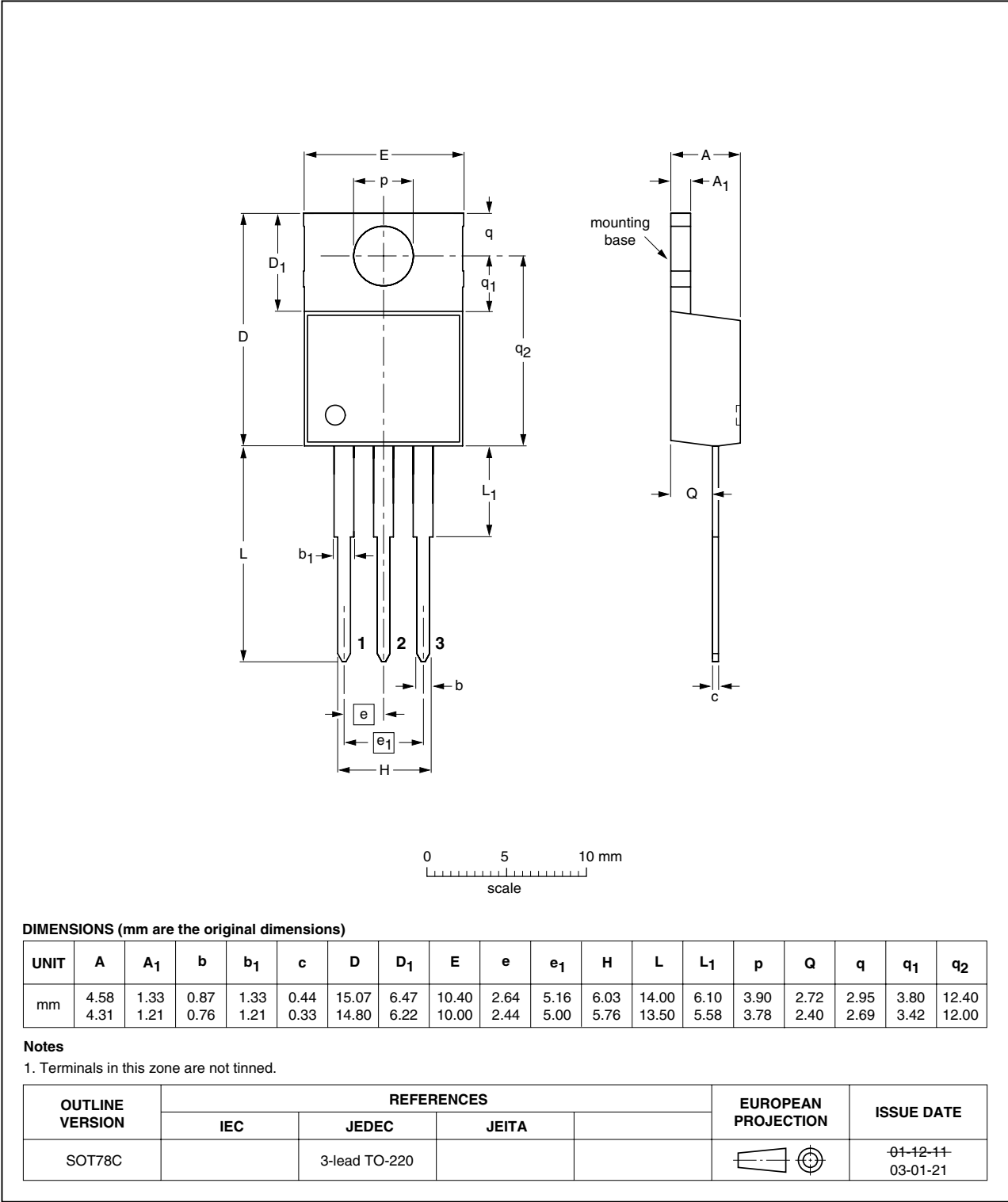


Fig 20. Package outline SOT78C (TO-220)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7L11-34ARC_5	20090217	Product data sheet	-	BUK7L11-34ARC_4
Modifications:	<ul style="list-style-type: none">The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.Legal texts have been adapted to the new company name where appropriate.			
BUK7L11-34ARC_4	20051216	Product data sheet	-	BUK7L11_34ARC-03
BUK7L11_34ARC-03 (9397 750 12163)	20031203	Product data sheet	-	BUK7L11_34ARC-02
BUK7L11_34ARC-02 (9397 750 11472)	20030522	Product data sheet	-	BUK7L11_34ARC-01
BUK7L11_34ARC-01 (9397 750 11178)	20030423	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

9.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

9.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.nxp.com/profile/terms>, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

TrenchMOS — is a trademark of NXP B.V.

10. Contact information

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: salesaddresses@nxp.com

11. Contents

1 Product profile1

1.1 General description1

1.2 Features and benefits1

1.3 Applications1

1.4 Quick reference data1

2 Pinning information2

3 Ordering information2

4 Limiting values3

5 Thermal characteristics5

6 Characteristics6

7 Package outline12

8 Revision history13

9 Legal information14

9.1 Data sheet status14

9.2 Definitions14

9.3 Disclaimers14

9.4 Trademarks14

10 Contact information14



Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

NXP:

[BUK7L11-34ARC](#)